


<b>Search Notes</b> 	<b>Application/Control No.</b> 10594451	<b>Applicant(s)/Patent Under Reexamination</b> KIRIYAMA ET AL.
	<b>Examiner</b> BRIAN MCCAIG	<b>Art Unit</b> 1797

SEARCHED			
Class	Subclass	Date	Examiner
502	208-211	1/20/2010	BAM
208	133-134	1/20/2010	BAM

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search (see attached)	1/20/2010	BAM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
208	133-134	1/20/2010	BAM
502	208-211	1/20/2010	BAM

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